



Date: October 1, 2004
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION <i>(Use several sheets if necessary)</i>	ATTY. DOCKET NO. BDL-445XX	APPLICATION NO. 10/765,426
	APPLICANT: Jean-Michel Larrieu, et al.	
	FILING DATE January 27, 2004	TC ART UNIT 1733 1728

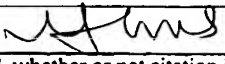
U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
AM	US 6,182,442 B1	2/6/2001	Schmidt, et al.	60	267	
AM	US 6,397,581 B1	6/4/2002	Vidal, et al.	60	267	
	US					
	US					
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	US					
	US					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER 	DATE CONSIDERED 05/12/2006
<small>*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>	

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EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
AM		US 6,134,785 A	10/24/2000	Walter et al.			
		US					
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AM		FR 2 785 664 A	5/12/2000	France			X
AM		EP 0 815 995 A	1/7/1998	EPO			X
AM		FR 2 774 432 A	8/6/1999	France			X
OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			
AM				05/12/2006			
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